

4096K (256K x 16) CMOS UV EPROM

VERY FAST ACCESS TIME: 100ns.

 COMPATIBLE TO HIGH SPEED MICROPRO-CESSORS ZERO WAIT STATE.

- LOW POWER "CMOS" CONSUMPTION:
 - Operating current 70mA at 10 MHz
 - standby current 100μA.
- PROGRAMMING VOLTAGE 12.75V.
- ELECTRONIC SIGNATURE FOR AUTOMATED PROGRAMMING.
- PROGRAMMING TIMES OF AROUND 24 SEC-ONDS (PRESTO II ALGORITHM).

DESCRIPTION

The M27C4002 is a high speed 4,194,304 (organized 262,144 \times 8) bit ultraviolet erasable and programmable EPROM ideally suited for applications where fast turn-around and pattern experimentation are important requirements.

It is housed in a 40 pin Window Ceramic Frit Seal package. The transparent lid allows the user to expose the chip to ultraviolet light to erase the bit pattern. A new pattern can then be written in the device by following the programming procedure.

PIN FUNCTIONS

A0-A17	ADDRESS INPUT
CE	CHIP ENABLE INPUT
OE	OUTPUT ENABLE
O0-O15	DATA INPUT/OUTPUT
V _{PP}	PROGRAMMING VOLTAGE
Vcc	+5V POWER SUPPLY
GND	GROUND

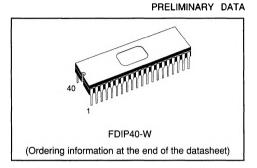
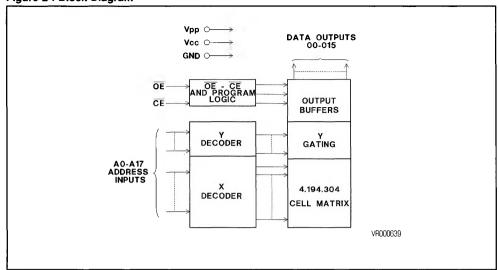


Figure 1: Pin Connection

Vpp [1	40	VCC
	2	39	A17
015	3	38	A16
	4	37	A15
	5	36	A14
	6	35	A13
	7	34]	A12
	8	33	A11
09	9	32	A10
08	10	31]	A9
GND	11	30	GND
07	12	29	A8
06	13	28]	A7
05	14	27]	A6
04	15	26	A5
03	16	25 🛭	A4
02	17	24	A3
01	18	23]	A2
00	19	22	A1
OE	20	21	AO
		VR	000640

Figure 2 : Block Diagram



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
Vi	Input or Output Voltages with respect to Ground	-0.6 to + 7.0	v
V _{PP}	Supply Voltage with respect to Ground	-0.6 to + 14.0	V
V _{A9}	Voltage on A9 with respect to Ground	-0.6 to + 13.5	V
Vcc	Supply Voltage with respect to Ground	-0.6 to + 7.0	V
T _{bias}	Temperature range under bias	-10 to + 125	°C
T _{stg}	Storage temperature range	- 65 to + 150	.c

NOTE: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

OPERATING MODES

MODE	CE	OE	A9	V _{PP}	OUTPUT
READ	L	L	X	х	D _{OUT}
OUTPUT DISABLE	L	Н	х	Х	HIGH Z
STANDBY	Н	х	х	х	HIGH Z
PROGRAM	L	Н	Х	V _{PP}	D _{IN}
PROGRAM VERIFY	Н	L	X	V _{PP}	D _{OUT}
PROGRAM INHIBIT	Н	Н	Х	V _{PP}	HIGH Z
ELECTRONIC SIGNATURE	L	L	V _H	VCC	CODE

NOTE : X = Don't Care ; $VH = 12V \pm 0.5V$; H = High ; L = Low

READ OPERATION DC AND AC CONDITIONS

SELECTION CODE	F1	F6	F7	F3
Operating Temperature Range	0 to 70°C	-40 to 85°C	-40 to 105°C	-40 to 125°C
SELECTION CODE (Example for 0°C to 70°C Oper. Temp. Range)		10XF1, 12XF1, 15XF1, 20XF1, 25XF1		, 20F1, 25F1
V _{CC} Power Supply (1)	5V ± 5%		5V ±	: 10%

NOTE: "F" Stands for Ceramic package.

DC AND OPERATING CHARACTERISTICS

Symbol	Parameter	Test Condition	Val	ues	Unit
Symbol	Parameter	rest Condition	Min	n Max	
lu	Input Leakage Current	V _{IN} = 0V to V _{CC}	-1	1	μА
llo	Output Leakage Current	V _{IN} = 0V to V _{CC}	-1	1	μА
lcc1	V _{CC} Active Current	CE = OE = V _{IL} , l _{OUT} = 0 mA (F = 10MHz)		70	mA
lcc1	V _{CC} Active Current	$\overline{CE} = \overline{OE} = V_{IL}, l_{OUT} = 0 mA$ (F = 5 MHz)		50	mA
I _{CC2}	VCC Standby Current - TTL	CE = V _{IH}		1	mA
Іссз	VCC Standby Current - CMOS	CE > V _{CC} -0.2 V		100	μА
I _{PP1}	V _{PP} Read Current	$V_{PP} = V_{CC}$		10	μA
VIL	Input Low Voltage		-0.3	0.8	٧
V _{IH}	Input High Voltage		2.0	V _{CC+} 1.0	٧
Vol	Output Low Voltage	I _{OL} = 2.1 mA		0.45	٧
V _{OH}	Output High Voltage	loн = -400 μA loн = -100 μA	2.4 V _{CC} - 0.7		V

AC CHARACTERISTICS

				27C4002									
Symbol	Parameter	Test Condition	-10		-10 -12		-15		-20		-25		Unit
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	}	
tacc	Address to Output Delay	CE=OE=VIL		100		120		150		200		250	ns
tce	CE to Output Delay	OE=V _{IL}		100		120		150		200		250	ns
toe	OE to Output Delay	CE=V _{IL}		50		60		60		70		100	ns
t _{DF}	OE High to Output Float	CE=V _{IL}	0	30	0	40	0	50	0	80	0	80	ns
tон	Output hold from address	CE=OE=VIL	0		0		0		0		0		ns

CAPACITANCE(3)

 $(T_A = 25^{\circ}C f = 1MHz)$

Symbol	Parameter	Test Condition	Max	Unit
Cin	Input Capacitance	V _{IN} = 0V	5	pF
Соит	Output Capacitance	V _{OUT} = 0V	5	pF

NOTES: 1. V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP} .

This parameter is only sampled and not 100 % tested. Output float is defined as the point where data is no longer driven (see timing table).

3. This parameter is only sampled and not 100 % tested.

AC TEST CONDITIONS

Output Rise and Fall Times:

≤ 20 ns

Timing Measurement Reference Levels:

Input Pulse Levels · 0.45 to 2.4V Inputs: 0.8 and 2V - Outputs: 0.8 and 2V

Figure 3: AC Testing input/Output Waveform

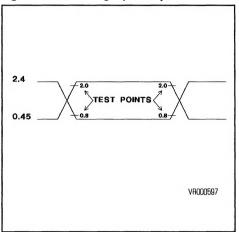


Figure 4: AC Testing Load Circuit

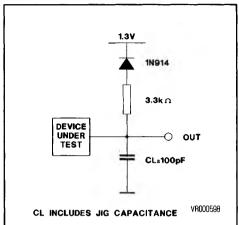
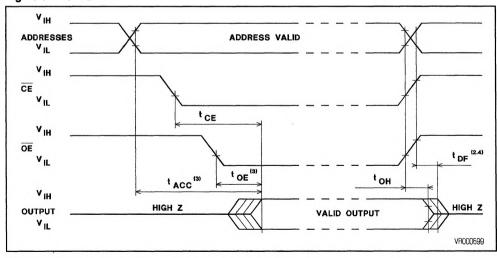


Figure 5 : AC Waveforms



NOTES: 1. Typical values are for TA = 25°C and nominal supply voltage.

2. This parameter is only sampled and not 100 % tested.

OE may be delayed up to tCE - tOE after the falling edge CE without impact on tCE.
 tor is specified from OE or CE whichever occurs first.

DEVICE OPERATION

The modes of operations of the M27C4002 are listed in the Operating Modes table. A single 5V power supply is required in the read mode. All inputs are TTL levels except for V_{pp} and 12V on A9 for Electronic Signature.

READ MODE

The M27C4002 has two control functions, both of which must be logically active in order to obtain data at the outputs. Chip Enable (CE) is the power control and should be used for device selection. Output Enable (OE) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that the addresses are stable, the addresses access time (tACC) is equal to the delay from CE to output (tCE). Data is available at the output after a delay of toe from the falling edge of OE, assuming that CE has been low and the addresses have been stable for at least tACC-tOE.

STANDBY MODE

The M27C4002 has a standby mode which reduces the active current from 50mA to 0.1mA. The M27C4002 is placed in the standby mode by applying a CMOS high signal to the CE input. When in the standby mode, the outputs are in a high impedance state, independent of the OE input.

TWO LINE OUTPUT CONTROL

Because EPROMs are usually used in larger memory arrays, the product features a 2 line control function which accommodates the use of multiple memory connection. The two line control function allows:

- a) the lowest possible memory power dissipation.
- b) complete assurance that output bus contention will not occur.

For the most efficient use of these two control lines, CE should be decoded and used as the primary device selecting function, while OE should be made a common connection to all devices in the array and connected to the READ line from the system control bus. This ensures that all deselected memory devices are in their low power standby mode and that the output pins are only active when data is required from a particular memory device.

SYSTEM CONSIDERATIONS

The power switching characteristics of CMOS-E4 EPROMs require careful decoupling of the devices.

The supply current, Icc, has three segments that are of interest to the system designer: the standby current level, the active current level, and transient current peaks that are produced by the falling and rising edges of CE. The magnitude of the transient current peaks is dependent on the output capacitive and inductive loading of the device. The associated transient voltage peaks can be suppressed by complying with the two line output control and by properly selected decoupling capacitors. It is recommended that a 1µF ceramic capacitor be used on every device between Vcc and GND. This should be a high frequency capacitor of low inherent inductance and should be placed as close to the device as possible. In addition, a 4.7µF bulk electrolytic capacitor should be used between Vcc and GND for every eight The bulk capacitor should be located devices. near the power supply connection point. The purpose of the bulk capacitor is to overcome the voltage drop caused by the inductive effects of PCB traces.

PROGRAMMING

Caution : exceeding 14V on V_{pp} pin will permanently damage the M27C4002.

When delivered (and after each erasure for UV EPROM), all bits of the M27C4002 are in the "1" state. Data is introduced by selectively programming "0s" into the desired bit locations. Although only "0s" will be programmed, both "1s" and "0s" can be present in the data word. The only way to change a "0" to a "1" is by die exposure to ultraviolet light (UV EPROM). The M27C4002 is in the programming mode when Vpp input is at 12.75V, and CE is at TTL-low. The data to be programmed is applied 16 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL. Vcc is specified to be 6.25V \pm 0.25V.

PRESTO II PROGRAMMING ALGORITHM

PRESTO II Programming Algorithm allows the whole array to be programmed with a guaranteed margin, in a typical time of less than 24 seconds. Programming with PRESTO II consists of applying a sequence of 100 microsecond program pulses to each byte until a correct verify occurs. During programming and verify operation, a MARGIN MODE circuit is automatically activated in order to guarantee that each cell is programmed with enough margin. No overprogram pulse is applied since the verify in MARGIN MODE provides necessary margin to each programmed cell.

DEVICE OPERATION (Continued)

PROGRAM INHIBIT

Programming of multiple M27C4002s in parallel with different data is also easily accomplished. Except for CE, all like inputs including OE of the parallel M27C4002 may be common. A TTL low level pulse applied to a M27C4002's CE input, with VPP at 12.75V, will program that M27C4002. A high level CE input inhibits the other M27C4002s from being programmed.

PROGRAM VERIFY

A verify (read) should be performed on the programmed bits to determine that they were correctly programmed. The verify is accomplished with OE at V_{IL} , CE at V_{IH} , V_{PP} at 12.75V and V_{CC} at 6.25V.

ELECTRONIC SIGNATURE

The Electronic Signature mode allows the reading out of a binary code from an EPROM that will identify its manufacturer and type. This mode is intended for use by programming equipment to automatically match the device to be programmed with its corresponding programming algorithm. This mode is functional in the $25^{\circ}C \pm 5^{\circ}C$ ambient temperature range that is required when programming the M27C4002. To activate this mode, the programming equipment must force 11.5V to 12.5V on address line A9 of the M27C4002 with $V_{PP} = V_{CC} = 5V$. Two identifier bytes may then be sequenced from the device outputs by togaling address line A0 from VIL to VIH. All other address lines must be held at VIL during Electronic Signature mode. Byte 0 (A0=V_{IL}) represents the manufacturer code and byte 1 (A0=V_{IH}) the device identifier code. For the SGS-THOMSON M27C4002, these two identifier bytes are given here below, and can be readout on outputs O0 to O7.

ERASURE OPERATION (applies for UV EPROM)

The erasure characteristics of the M27C4002 is such that erasure begins when the cells are exposed to light with wavelengths shorter than approximately 4000 Angstrom. It should be noted that sunlight and some type of fluorescent lamps have wavelengths in the 3000-4000 Å range. Research shows that constant exposure to room level fluorescent lighting could erase a typical M27C4002 in about 3 years, while it would take approximately 1 week to cause erasure when exposed to direct sunlight. If the M27C4002 is to be exposed to these types of lighting conditions for extended periods of time, it is suggested that opaque labels be put over the M27C4002 window to prevent unintentional erasure. The recommended erasure procedure for the M27C4002 is exposure to short wave ultraviolet light which has wavelength 2537 Å. The integrated dose (i.e. UV intensity x exposure time) for erasure should be a minimum of 15 W-sec/cm2. The erasure time with this dosage is approximately 15 to 20 minutes using an ultraviolet lamp with 12000 μW/cm2 power rating. The M27C4002 should be placed within 2.5cm (1 inch) of the lamp tubes during the erasure. Some lamps have a filter on their tubes which should be removed before erasure.

ELECTRONIC SIGNATURE MODE

IDENTIFIER		_			PI	NS				
IDENTIFIER	A0	07	06	O5	04	О3	O2	01	00	Hex
MANUFACTURER CODE	VIL	0	0	1	0	0	0	0	0	20
DEVICE CODE	VIH	0	1	0	0	0	1	0	0	44

NOTE : A9 = 12.0V \pm 0.5V ; $\overline{\text{CE}}$ = $\overline{\text{OE}}$ = V_{IL} ; A1 to A8 = A10 to A17 = V_{IL} ; V_{CC} = V_{PP} = 5V

PROGRAMMING OPERATION

 $(T_A = 25^{\circ}C \pm 5^{\circ}C, V_{CC}^{(1)} = 6.25V \pm 0.25, V_{PP}^{(1)} = 12.75V \pm 0.25V)$

DC AND OPERATING CHARACTERISTICS

Symbol	Parameter	Test Condition	Va	Values		
Зушьог	Parameter	(see note 1)	Min	Max	Unit	
ILI	Input Current (All Inputs)	$V_{IN} = 0V$ to V_{CC}	-10	+10	μА	
VIL	Input Low Level (All Inputs)		-0.1	0.8	٧	
VIH	Input High Level		2.4	V _{CC} +0.5	٧	
V _{OL}	Output Low Voltage During Verify	I _{OL} = 2.1 mA		0.45	V	
V _{OH}	Output High Voltage During Verify	Іон = -400μΑ	2.4		٧	
I _{CC2}	V _{CC} Supply Current			50	mA	
l _{PP2}	V _{PP} Supply Current (program)	CE = VIL		50	mA	
V _{ID}	A9 Electronic Signature Voltage		11.5	12.5	٧	

AC CHARACTERISTICS

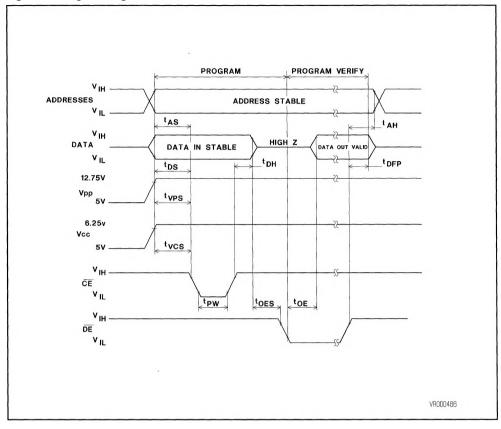
Symbol	Parameter	Test Condition	Val	Values		
Syllibol	Parameter	(see note 1)	Min	Max	Unit	
tas	Address Setup Time		2		μs	
toes	OE Setup Time		2		μs	
tos	Data Setup Time		2		μѕ	
tah	Address Hold Time		0		μs	
t _{DH}	Data Hold Time		2		μs	
t _{DFP(2)}	Outpout Enable Output Float Delay		0	130	ns	
tvps	V _{PP} Setup Time		2		μs	
tvcs	V _{CC} Setup Time		2		μs	
t _{PW}	Initial Program Pulse Width		95	105	μs	
toe	Data Valid from OE			100	ns	

NOTES: 1. V_{CC} must be applied simultaneously or before V_{PP} and removed simultaneously or after V_{PP} .

This parameter is only sampled and not 100 % tested.Output Float is defined as the point where data is no longer driven (see timing diagram).

PROGRAMMING OPERATION (Continued)

Figure 6: Programming Waveforms



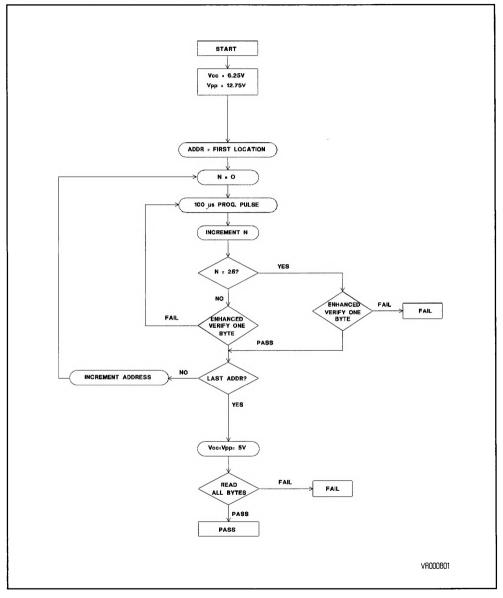
NOTES: 1. The input timing reference level is 0.8V for a V_{IL} and 2V for a V_{IH} .

2. toe and topp are characteristics of the device but must be accommodated by the programmer.

When programming the M27C4002 a 0.1μF capacitor is required accross V_{PP} and GND to suppress spurious voltage transients which can damage the device.

PROGRAMMING OPERATION (Continued)

Figure 7: PRESTO II Programming Algorithm Flow Chart



ORDERING INFORMATION (UV EPROM)

Part Number	Access Time	Supply Voltage	Temp.Range	Package
M27C4002-10XF1	100 ns	5V +/- 5 %	0 to + 70°C	FDIP40-W
M27C4002-12XF1	120 ns	5V +/- 5 %	0 to + 70°C	FDIP40-W
M27C4002-15XF1	150 ns	5V +/- 5 %	0 to + 70°C	FDIP40-W
M27C4002-20XF1	200 ns	5V +/- 5 %	0 to + 70°C	FDIP40-W
M27C4002-25XF1	250 ns	5V +/- 5 %	0 to + 70°C	FDIP40-W
M27C4002-12F1	120 ns	5V +/- 10 %	0 to + 70°C	FDIP40-W
M27C4002-15F1	150 ns	5V +/- 10 %	0 to + 70°C	FDIP40-W
M27C4002-20F1	200 ns	5V +/- 10 %	0 to + 70°C	FDIP40-W
M27C4002-25F1	250 ns	5V +/- 10 %	0 to + 70°C	FDIP40-W

PACKAGE MECHANICAL DATA

Figure 8: 40-PIN WINDOW CERAMIC DUAL IN LINE FRIT-SEAL (F)

